# **Power MOSFET**

## 20 Amps, 30 Volts, N-Channel DPAK

This logic level vertical power MOSFET is a general purpose part that provides the "best of design" available today in a low cost power package. Avalanche energy issues make this part an ideal design in. The drain-to-source diode has a ideal fast but soft recovery.

#### **Features**

- Ultra-Low R<sub>DS(on)</sub>, Single Base, Advanced Technology
- SPICE Parameters Available
- Diode is Characterized for use in Bridge Circuits
- I<sub>DSS</sub> and V<sub>DS(on)</sub> Specified at Elevated Temperatures
- High Avalanche Energy Specified
- ESD JEDAC rated HBM Class 1, MM Class A, CDM Class 0
- AEC Q101 Qualified NVD20N03L27
- These Devices are Pb-Free and are RoHS Compliant

### **Typical Applications**

- Power Supplies
- Inductive Loads
- PWM Motor Controls
- Replaces MTD20N03L in many Applications

### MAXIMUM RATINGS (T<sub>C</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	30	Vdc
Drain-to-Gate Voltage ( $R_{GS} = 1.0 \text{ M}\Omega$ )	$V_{DGR}$	30	Vdc
Gate-to-Source Voltage - Continuous - Non-Repetitive (t <sub>p</sub> ≤10 ms)	V <sub>GS</sub> V <sub>GS</sub>	±20 ±24	Vdc
$ \begin{array}{ll} \text{Drain Current} \\ & - \text{ Continuous } @ \text{ T}_A = 25^{\circ}\text{C} \\ & - \text{ Continuous } @ \text{ T}_A = 100^{\circ}\text{C} \\ & - \text{ Single Pulse } (t_p \! \leq \! 10 \ \mu\text{s}) \end{array} $	I <sub>D</sub> I <sub>D</sub> I <sub>DM</sub>	20 16 60	Adc Apk
Total Power Dissipation @ T <sub>A</sub> = 25°C Derate above 25°C Total Power Dissipation @ T <sub>C</sub> = 25°C (Note 1)	P <sub>D</sub>	74 0.6 1.75	W W/°CW
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C
	E <sub>AS</sub>	288	mJ
Thermal Resistance  - Junction-to-Case  - Junction-to-Ambient  - Junction-to-Ambient (Note 1)	$egin{array}{c} R_{ heta JC} \ R_{ heta JA} \ R_{ heta JA} \end{array}$	1.67 100 71.4	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

 When surface mounted to an FR4 board using the minimum recommended pad size and repetitive rating; pulse width limited by maximum junction temperature.

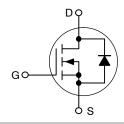


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20 A, 30 V,  $R_{DS(on)}$  = 27 m $\Omega$ 

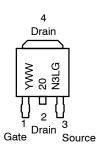
#### N-Channel



### MARKING DIAGRAMS



DPAK CASE 369C STYLE 2



20N3L = Device Code
Y = Year
WW = Work Week
G = Pb-Free Package

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	(Note 2)	V <sub>(BR)DSS</sub>				Vdc
$(V_{GS} = 0 \text{ Vdc}, I_D = 250 \mu\text{Adc})$			30	-	-	
Temperature Coefficient (Positive)			-	43	_	mV/°C
Zero Gate Voltage Drain Current		I <sub>DSS</sub>				μAdc
$(V_{DS} = 30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$			-	-	10	
$(V_{DS} = 30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_{J} = 150^{\circ}\text{C})$			-	-	100	
Gate-Body Leakage Current (V <sub>GS</sub> = ±20 Vdc, V <sub>DS</sub> = 0 Vdc)		$I_{GSS}$	-	_	±100	nAdc
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage (Note 2)		$V_{GS(th)}$				Vdc
$(V_{DS} = V_{GS}, I_{D} = 250 \mu\text{Adc})$			1.0	1.6	2.0	
Threshold Temperature Coefficient (N	legative)		_	5.0	_	mV/°C
Static Drain-to-Source On-Resistan	ce (Note 2)	R <sub>DS(on)</sub>				mΩ
$(V_{GS} = 4.0 \text{ Vdc}, I_D = 10 \text{ Adc})$			-	28	31	
(V <sub>GS</sub> = 5.0 Vdc, I <sub>D</sub> = 10 Adc)				23	27	
Static Drain-to-Source On-Voltage (	Note 2)	$V_{DS(on)}$				Vdc
$(V_{GS} = 5.0 \text{ Vdc}, I_D = 20 \text{ Adc})$	F0°C)		_	0.48	0.54	
$(V_{GS} = 5.0 \text{ Vdc}, I_D = 10 \text{ Adc}, T_J = 10 \text{ Adc})$			-	0.40	_	
Forward Transconductance (Note 2) (V <sub>DS</sub> = 5.0 Vdc, I <sub>D</sub> = 10 Adc)		9FS	_	21	-	mhos
DYNAMIC CHARACTERISTICS					T	
Input Capacitance	(V <sub>DS</sub> = 25 Vdc, V <sub>GS</sub> = 0 Vdc,	$C_{iss}$	_	1005	1260	pF
Output Capacitance	$(V_{DS} = 25 \text{ VdC}, V_{GS} = 0 \text{ VdC},$ f = 1.0  MHz)	C <sub>oss</sub>	-	271	420	
Transfer Capacitance	,	$C_{rss}$	-	87	112	
SWITCHING CHARACTERISTICS (No	te 3)					
Turn-On Delay Time		t <sub>d(on)</sub>	-	17	25	ns
Rise Time	$(V_{DD} = 20 \text{ Vdc}, I_D = 20 \text{ Adc},$	t <sub>r</sub>	-	137	160	
Turn-Off Delay Time	$V_{GS} = 5.0 \text{ Vdc},$ $R_{G} = 9.1 \Omega) \text{ (Note 2)}$	t <sub>d(off)</sub>	-	38	45	
Fall Time	rig = 0.1 22) (11010 2)	t <sub>f</sub>	-	31	40	
Gate Charge		Q <sub>T</sub>	_	13.8	18.9	nC
-	$(V_{DS} = 48 \text{ Vdc}, I_D = 15 \text{ Adc},$	Q <sub>1</sub>	_	2.8	_	
	V <sub>GS</sub> = 10 Vdc) (Note 2)	$Q_2$	-	6.6	_	
SOURCE-DRAIN DIODE CHARACTE	RISTICS	_	•	•	•	
Forward On-Voltage		V <sub>SD</sub>				Vdc
	(I <sub>S</sub> = 20 Adc, V <sub>GS</sub> = 0 Vdc) (Note 2)	- 3D	_	1.0	1.15	
	$(I_S = 20 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$		-	0.9	_	
Reverse Recovery Time		t <sub>rr</sub>	-	23	_	ns
-	$(I_S = 15 \text{ Adc}, V_{GS} = 0 \text{ Vdc},$	t <sub>a</sub>	-	13	_	
	$dl_{S}/dt = 100 A/\mu s)$ (Note 2)	t <sub>b</sub>	_	10	_	
Reverse Recovery Stored Charge	- , , , , ,	Q <sub>RR</sub>		0.017	_	μC
ricvolse riecovery stored charge		<b>∨</b> HH		0.017		μΟ

<sup>2.</sup> Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTD20N03L27T4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD20N03L27T4G	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

<sup>3.</sup> Switching characteristics are independent of operating junction temperature.

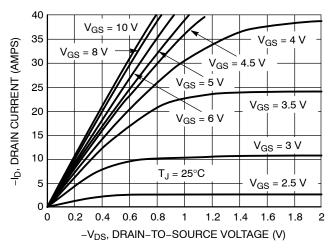


Figure 1. On-Region Characteristics

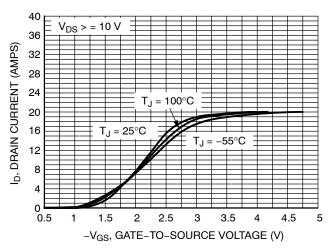


Figure 2. Transfer Characteristics

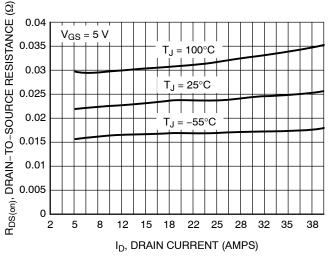


Figure 3. On-Resistance vs. Drain Current and **Temperature** 

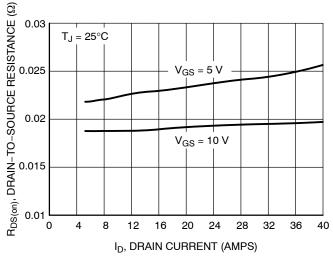


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

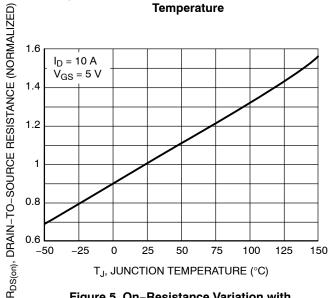


Figure 5. On-Resistance Variation with **Temperature** 

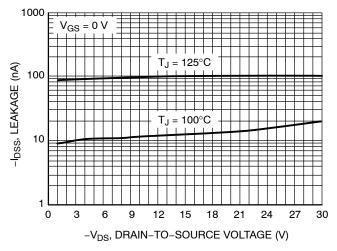


Figure 6. Drain-to-Source Leakage Current vs. Voltage

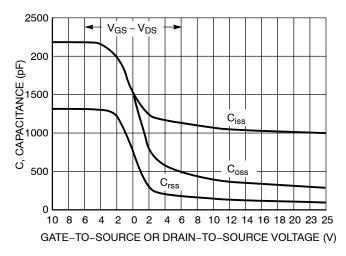


Figure 7. Capacitance Variation

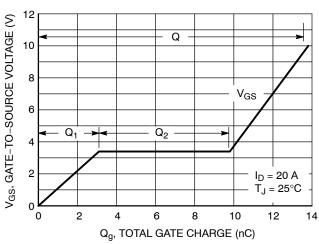


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

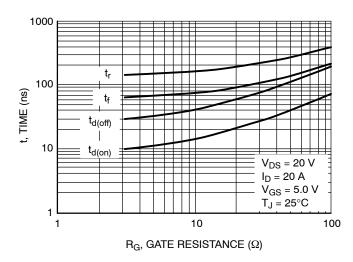


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

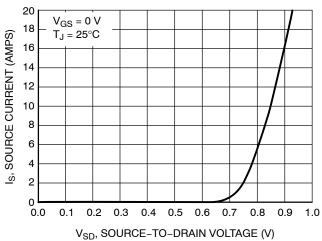


Figure 10. Diode Forward Voltage vs. Current

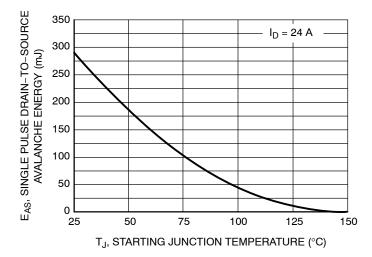
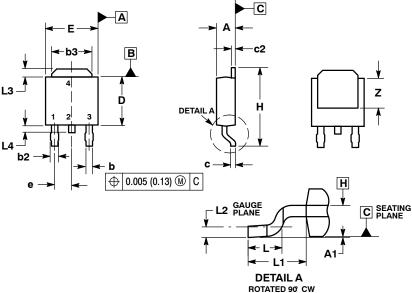


Figure 11. Maximum Avalanche Energy vs. Starting Junction Temperature

### PACKAGE DIMENSIONS

### **DPAK (SINGLE GAUGE)**

CASE 369C-01 ISSUE D



#### NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME
  - Y14.5M, 1994. CONTROLLING DIMENSION: INCHES
- 2. OF THOLLING DIMENSION. INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

  5. DIMENSIONS D. AND E ADE DETERMINED AT THE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

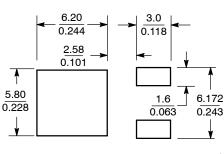
	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74 REF	
L2	0.020	0.020 BSC		BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

STYLE 2: PIN 1. GATE

2. DRAIN 3. SOURCE

DRAIN

### **SOLDERING FOOTPRINT\***



SCALE 3:1

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<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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